



FQB22P10TM_F085

100V P-Channel MOSFET

General Description

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

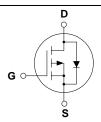
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

Features

- -22A, -100V, $R_{DS(on)} = 0.125\Omega$ @ $V_{GS} = -10 \text{ V}$
- Low gate charge (typical 40 nC)
- Low Crss (typical 160 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- 175°C maximum junction temperature rating
- · Qualified to AEC Q101
- RoHS Compliant



D²-PAK FQB Series



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB22P10TM_F085	Units	
V _{DSS}	Drain-Source Voltage		-100	V	
I _D	Drain Current - Continuous (T _C = 25°C)		-22	Α	
	- Continuous (T _C = 100°C)		-15.6	Α	
et4U _{DM} m	Drain Current - Pulsed	(Note 1)	-88	Α	
V _{GSS}	Gate-Source Voltage		±30	V	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		710	mJ	
I _{AR}	Avalanche Current (Note 1)		-22	Α	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	12.5	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-6.0	V/ns	
P _D	Power Dissipation (T _A = 25°C) *		3.75	W	
	Power Dissipation (T _C = 25°C) - Derate above 25°C		125	W	
			0.83	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C	
T _L	Maximum lead temperature for soldering	300	°C		

Thermal Characteristics

* When mounted on the minimum pad size recommended (PCB Mount)

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Symbol	Parameter	Тур	Max	Units	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.2	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aractariation					
	aracteristics	N 071 050 A			I	
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-100			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-0.1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -100 V, V _{GS} = 0 V			-1	μΑ
		V _{DS} = -80 V, T _C = 125°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-2.0		-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -11 A		0.096	0.125	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -40 V, I _D = -11 A (Note 4)		13.5		S
Dynam	ic Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$		1170	1500	pF
Coss	Output Capacitance	f = 1.0 MHz		460	600	pF
C _{rss}	Reverse Transfer Capacitance			160	200	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V - 50 V I - 20 A		17	45	ns
t _r	Turn-On Rise Time	$V_{DD} = -50 \text{ V}, I_{D} = -22 \text{ A},$		170	350	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25 \Omega$		60	130	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		110	230	ns
Q _g	Total Gate Charge	V _{DS} = -80 V, I _D = -22 A,		40	50	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -10 \text{ V}$		7.0		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		21		nC

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I _S	Maximum Continuous Drain-Source Diode Forward Current				-22	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				-88	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = -22 A			-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_{S} = -22 \text{ A,}$		110		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		0.6		μC

- **Notes:** 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.2mH, I_{AS} = -22A, V_{DD} = -25V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} \leq -22A, di/dt \leq 300A/µs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

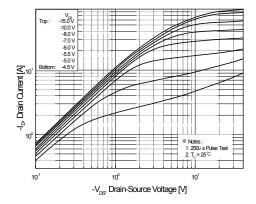


Figure 1. On-Region Characteristics

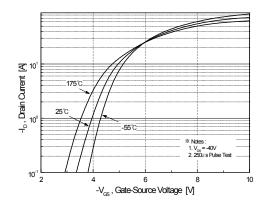


Figure 2. Transfer Characteristics

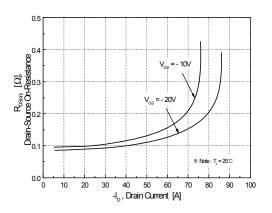


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

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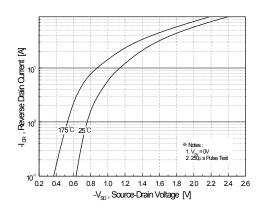


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

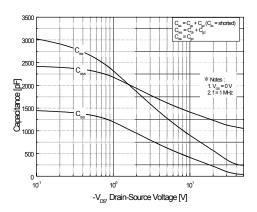


Figure 5. Capacitance Characteristics

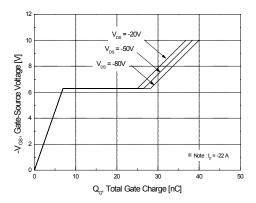
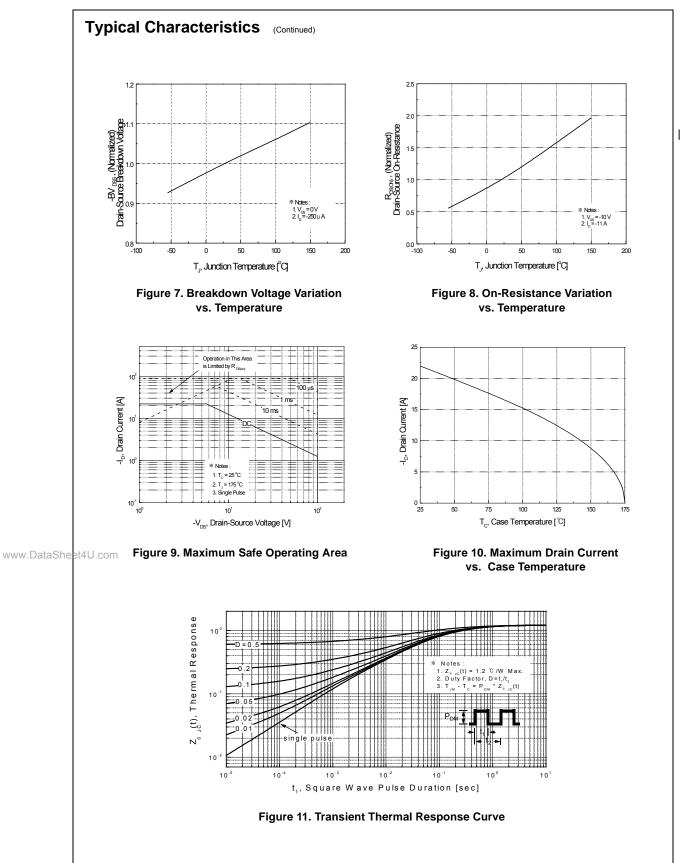
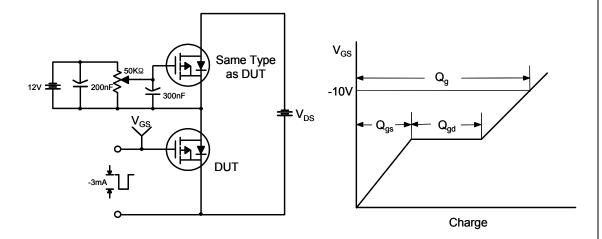


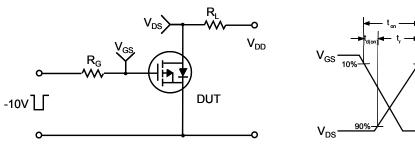
Figure 6. Gate Charge Characteristics



Gate Charge Test Circuit & Waveform



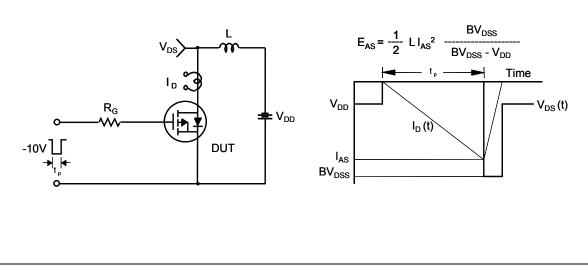
Resistive Switching Test Circuit & Waveforms



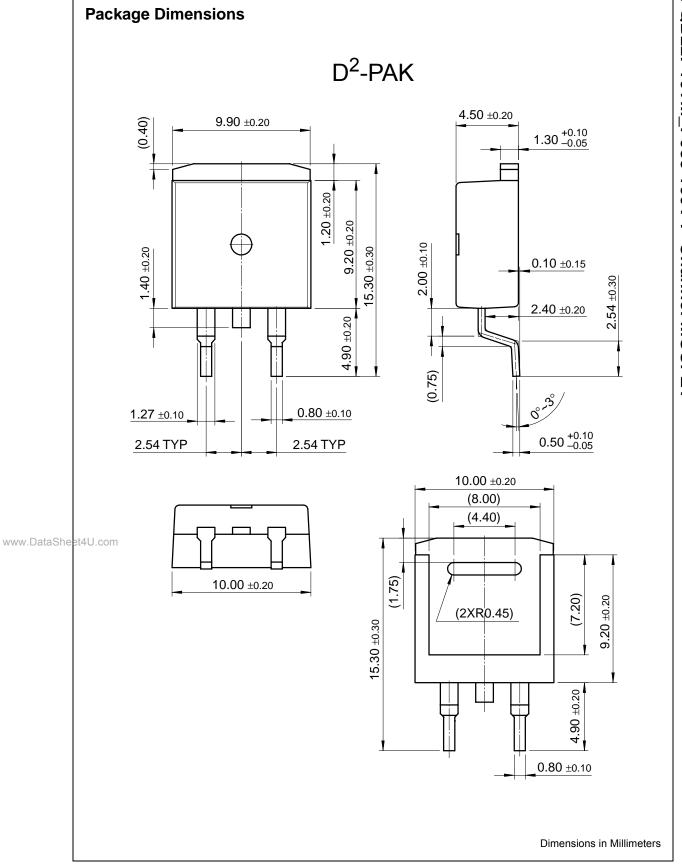
V_{GS} 10%

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Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms DUT Driver Compliment of DUT V_{DD} (N-Channel) • dv/dt controlled by R_G • I_{SD} controlled by pulse period Gate Pulse Width V_{GS} Gate Pulse Period 10V (Driver) **Body Diode Reverse Current** \mathbf{I}_{SD} www.DataSheet4U.com (DUT) I_{RM} di/dt I_{FM} , Body Diode Forward Current \mathbf{V}_{DS} (DUT) Body Diode Forward Voltage Drop Body Diode Recovery dv/dt







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